

Search Notes**Application/Control No.**

10/677,559

Examiner

Hien X. Vo

Applicant(s)/Patent under Reexamination

YE ET AL.

Art Unit

2863

SEARCHED

Class	Subclass	Date	Examiner
702	60 65	4/17/2005	VXH
290	40B 40C		
307	30 45		
318	762 763		
	767		
361	60 62		
363	109 116 120		
700	286 292		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	4/17/2005	VXH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner